

SEARCHED			
Class	Sub.	Date	Exmr.
702	57 63-67 80, 118 179-124 177, 183 184 189, 190	8/1/03 ↓ 8/2/03 ↓	Mc ↓
714	45 724 725 736		
455	573		
Search updated		12/29/03	Mc

INTERFERENCE SEARCHED			
Class	Sub.	Date	Exmr.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	Date	Exmr.
Test Search in East ((device or devices) with (test or tests or testing or tested)) and (eeprom or eprom) and (display or displays or displaying or displayed) and (compare or compared or comparing or compares) with (signal or signals) and (program or programs or programmed)	8/2/03	Mc
IEEE by Inventor's name	8/4/03	Mc
Test search updated	12/29/03	Mc

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